Search Notes



Application/Control	No.

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Applicant(s)/Patent Under Reexamination

MIURA ET AL.

Examiner

DEREK S CHAPEL

Art Unit

2872

SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES

Search Notes	Date	Examiner
Consulted with Arnel Lavarias about the case	4/10/2008	DSC
EAST Class/Subclass Search: 359/1, 3, 10, 15, 28, 30, 32, 34-35, 900	4/9/2008	DSC
(text only)		
EAST text search	4/9/2008	DSC
EAST Class/Subclass Search: 369/93-94, 99, 103, 272.1, 275.1-275.2	11/25/2008	DSC
(text only)		
EAST Update Search	11/25/2008	DSC
Consulted with Arnel Lavarias about the rejections.	11/25/2008	DSC
EAST Update Search	3/10/2009	DSC

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
	Interference Search, see .clm. search	4/11/2008	DSC
	Updated Interference Search, see .clm. search	11/25/2008	DSC
	Updated Interference Search, see .clm. search attached	3/10/2009	DSC

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